

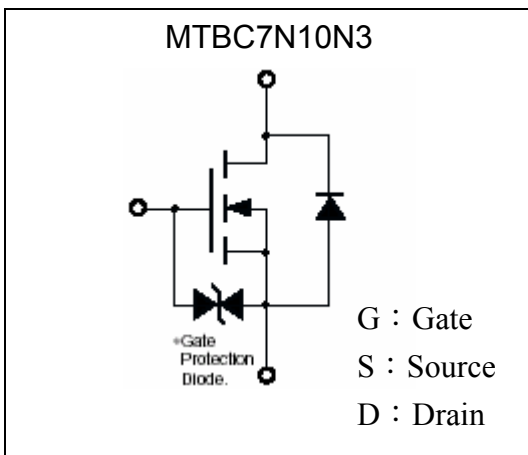
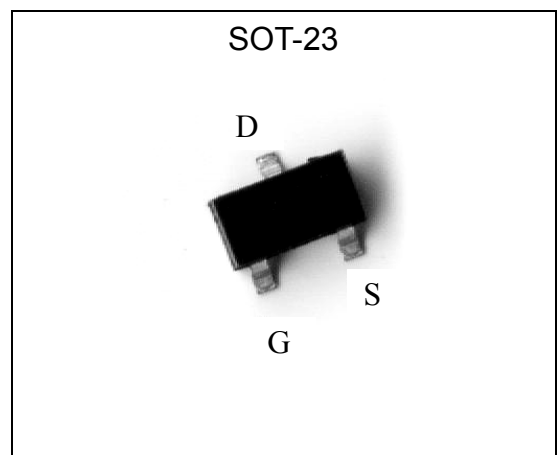
**100V N-Channel Logic Level Enhancement Mode MOSFET**

# MTBC7N10N3

$BV_{DSS}$	100V
$I_D$	1A
$R_{DSON(TYP)}@V_{GS}=10V, I_D=1A$	389m $\Omega$
$R_{DSON(TYP)}@V_{GS}=4.5V, I_D=1A$	413m $\Omega$
$R_{DSON(TYP)}@V_{GS}=4V, I_D=1A$	407m $\Omega$

**Features**

- Lower gate charge.
- ESD protected.
- Pb-free lead plating and Halogen-free package.

**Equivalent Circuit**

**Outline**

**Absolute Maximum Ratings** ( $T_C=25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	$T_A=25^\circ\text{C}, V_{GS}=10\text{V}$	1
		$T_A=70^\circ\text{C}, V_{GS}=10\text{V}$	0.8
Pulsed Drain Current	$I_{DM}$	4 (Note 1 & 2)	A
Power Dissipation	$P_D$	1 (Note 3)	W
		0.54 (Note 4)	
Operating Junction and Storage Temperature	$T_j, T_{stg}$	-55 ~ +150	$^\circ\text{C}$



**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-ambient, max	R <sub>th,j-a</sub>	125 (Note 3)	°C/W
Thermal Resistance, Junction-to-ambient, max	R <sub>th,j-a</sub>	231 (Note 4)	°C/W

- Note : 1. Pulse width limited by maximum junction temperature.  
 2. Duty cycle ≤ 1%.  
 3. Surface mounted on a ceramic board (30×30×0.8mm), t ≤ 10s.  
 4. Surface mounted on a FR-4 board (12×20×0.8mm), t ≤ 10s; 357°C/W when mounted on min. copper pad.

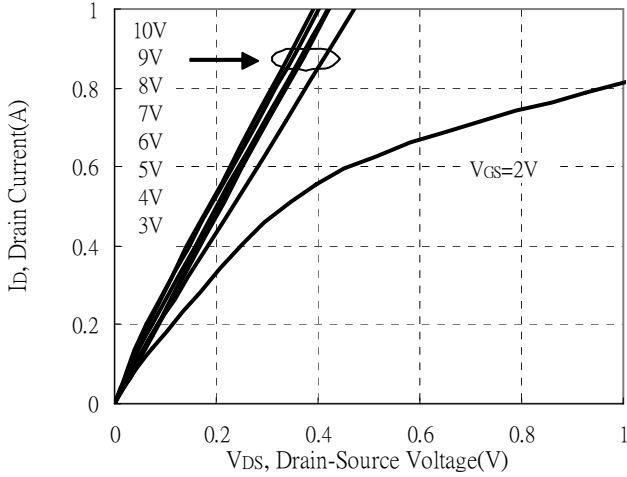
**Electrical Characteristics** (T<sub>A</sub>=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250μA
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	-	107	-	mV/°C	I <sub>D</sub> =1mA, referenced to 25°C
V <sub>GS(th)</sub>	1	1.3	2.5	V	V <sub>DS</sub> =10V, I <sub>D</sub> =1mA
ΔV <sub>GS(th)</sub> /ΔT <sub>j</sub>	-	-3	-	mV/°C	I <sub>D</sub> =1mA, referenced to 25°C
I <sub>GSS</sub>	-	-	±10	μA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	1		V <sub>DS</sub> =100V, V <sub>GS</sub> =0
	-	-	10	V <sub>DS</sub> =80V, V <sub>GS</sub> =0, T <sub>j</sub> =125°C	
*R <sub>DS(ON)</sub> <sup>1</sup>	-	389	520	mΩ	I <sub>D</sub> =1A, V <sub>GS</sub> =10V
	-	407	560		I <sub>D</sub> =1A, V <sub>GS</sub> =4.5V
	-	413	580		I <sub>D</sub> =1A, V <sub>GS</sub> =4V
*G <sub>FS</sub> <sup>1</sup>	1	2.4	-	S	I <sub>D</sub> =1A, V <sub>GS</sub> =10V
<b>Dynamic</b>					
C <sub>iss</sub>	-	108	-	pF	V <sub>DS</sub> =25V, V <sub>GS</sub> =0, f=1MHz
C <sub>oss</sub>	-	13	-		
C <sub>rss</sub>	-	5.2	-		
*t <sub>d(ON)</sub> <sup>1 2</sup>	-	5	-	ns	V <sub>DS</sub> =50V, I <sub>D</sub> =0.5A, V <sub>GS</sub> =10V, R <sub>G</sub> =10Ω
*t <sub>r</sub> <sup>1 2</sup>	-	6	-		
*t <sub>d(OFF)</sub> <sup>1 2</sup>	-	18	-		
*t <sub>f</sub> <sup>1 2</sup>	-	10	-		
*Q <sub>g</sub> <sup>1 2</sup>	-	2.9	-	nC	V <sub>DS</sub> =50V, I <sub>D</sub> =1A, V <sub>GS</sub> =5V
*Q <sub>gs</sub> <sup>1 2</sup>	-	0.3	-		
*Q <sub>gd</sub> <sup>1 2</sup>	-	1	-		
<b>Source-Drain Diode</b>					
I <sub>S</sub>	-	-	0.8	A	
V <sub>SD</sub> <sup>1</sup>	-	0.8	1.2	V	I <sub>S</sub> =1A, V <sub>GS</sub> =0V

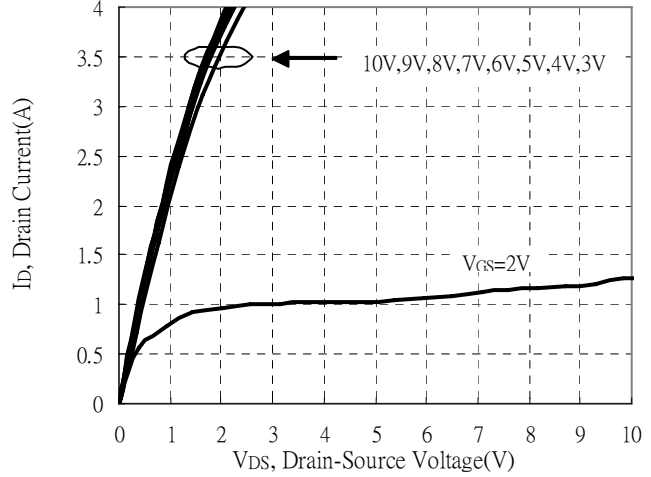
<sup>1</sup> Pulse test : Pulse width ≤ 300μs, Duty cycle ≤ 2%  
<sup>2</sup> Independent of operating temperature  
<sup>3</sup> Pulse width limited by maximum junction temperature

**Typical Characteristics**

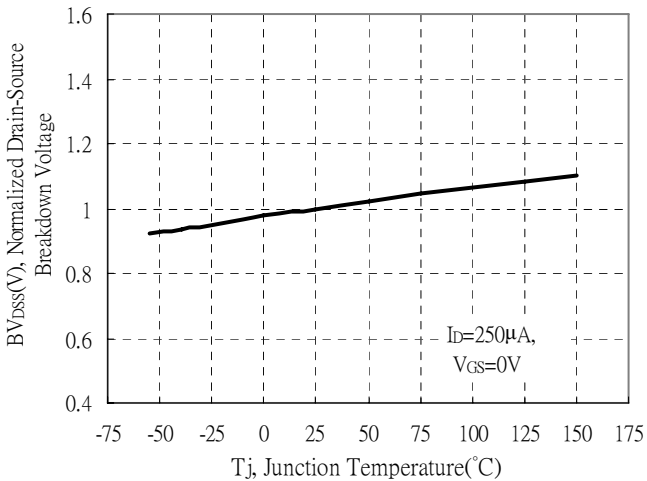
Typical Output Characteristics



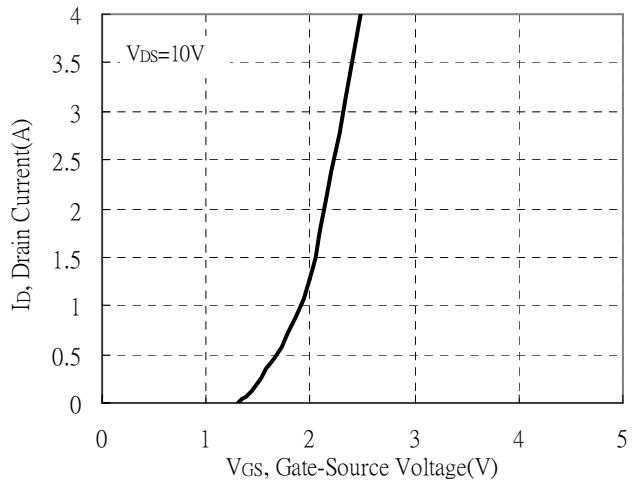
Typical Output Characteristics



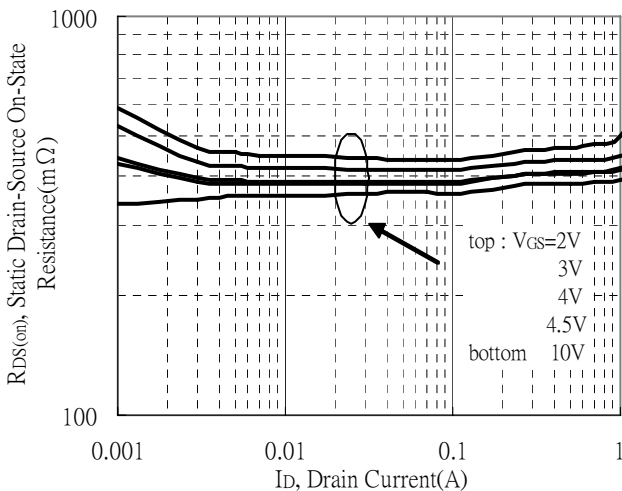
Brekdown Voltage vs Ambient Temperature



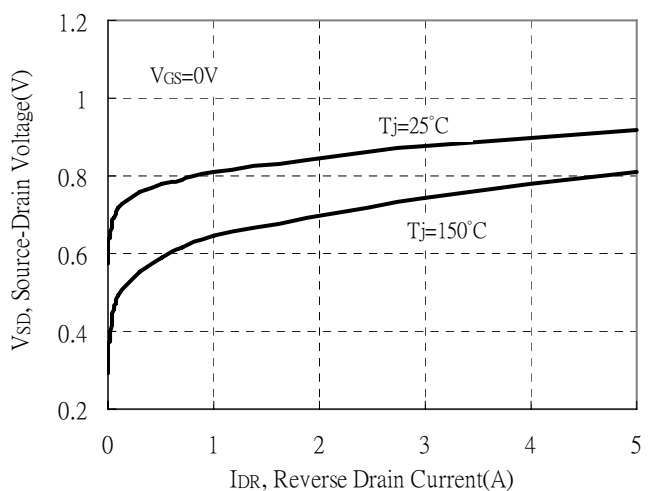
Typical Transfer Characteristics



Static Drain-Source On-State resistance vs Drain Current



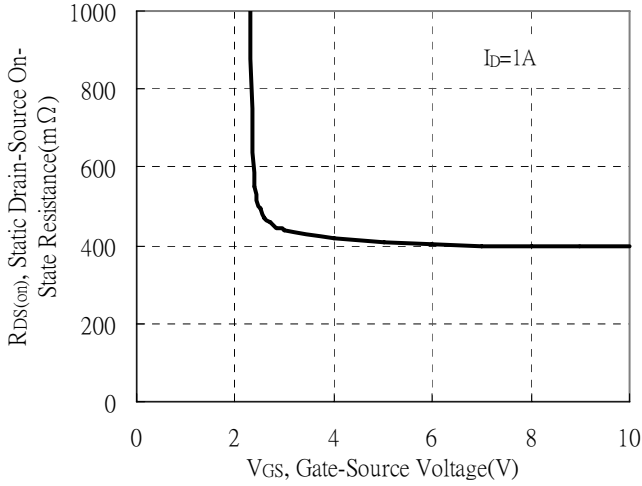
Reverse Drain Current vs Source-Drain Voltage



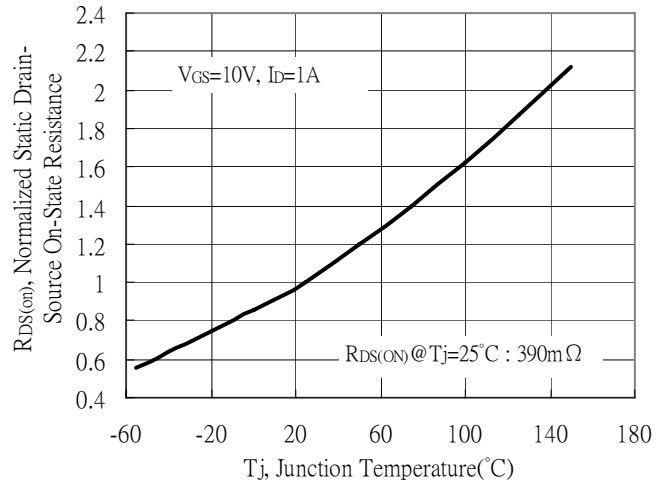


### Typical Characteristics(Cont.)

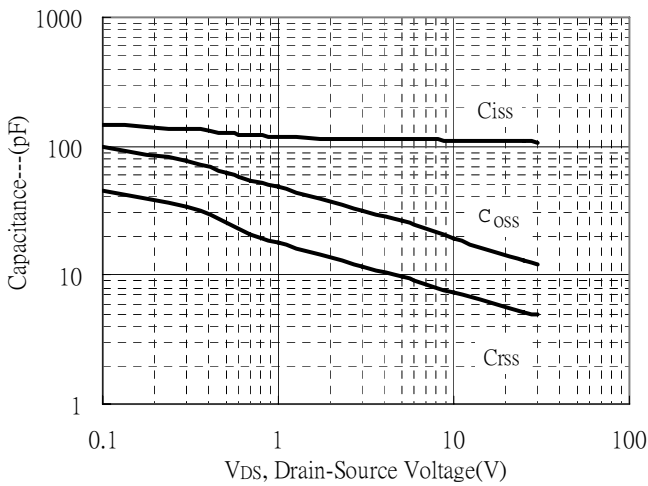
Static Drain-Source On-State Resistance vs Gate-Source Voltage



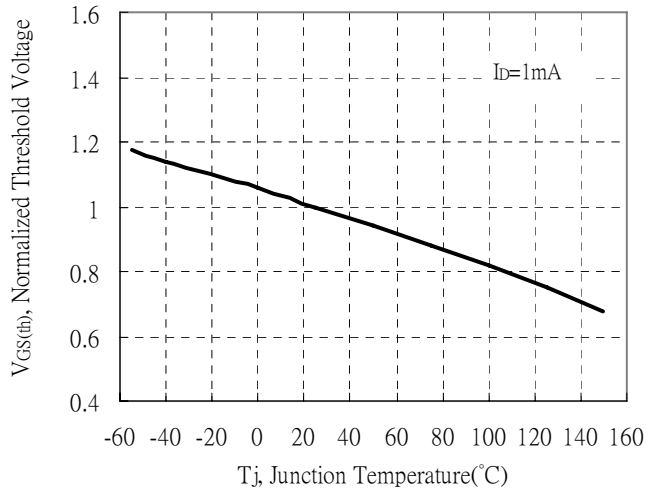
Drain-Source On-State Resistance vs Junction Temperature



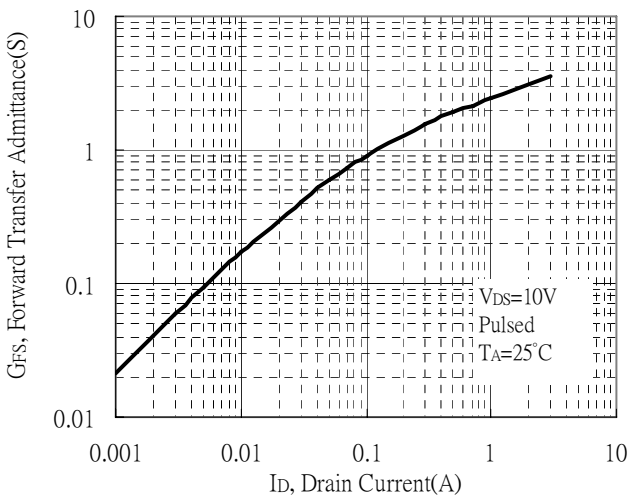
Capacitance vs Drain-to-Source Voltage



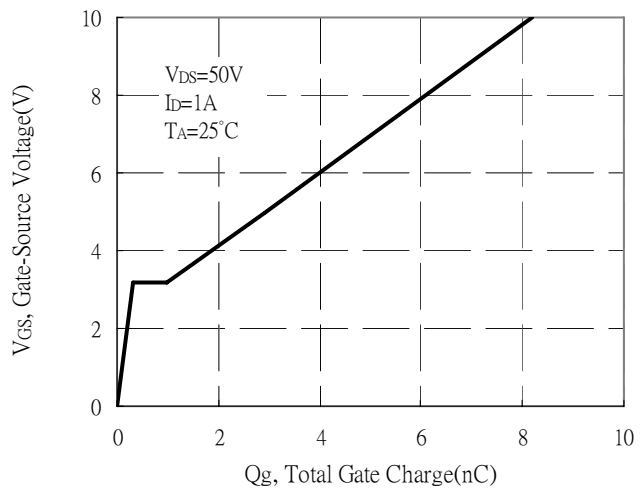
Threshold Voltage vs Junction Temperature



Forward Transfer Admittance vs Drain Current



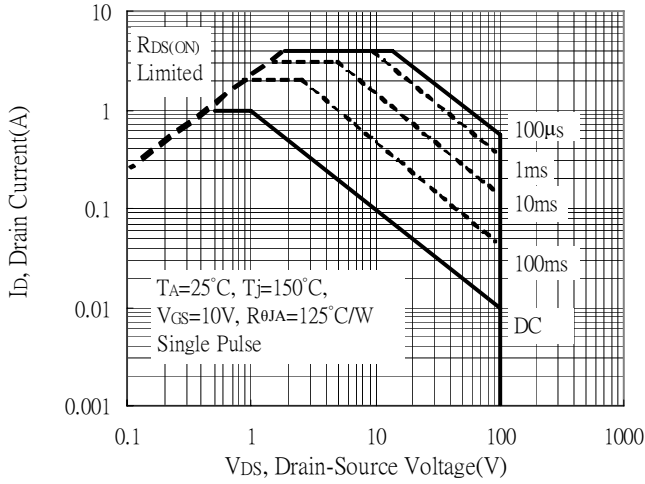
Gate Charge Characteristics



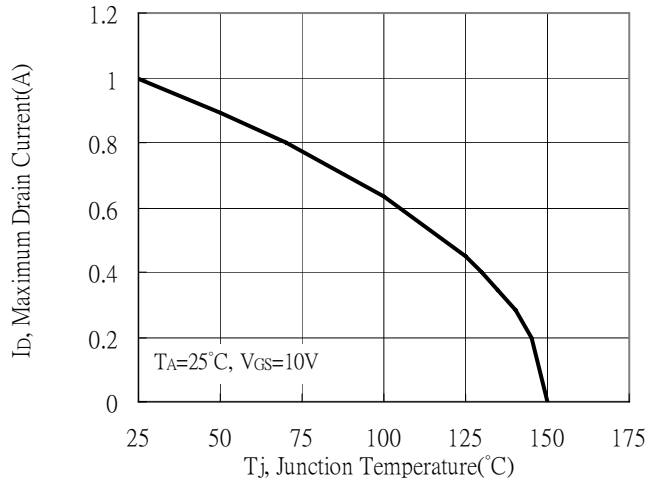


**Typical Characteristics(Cont.)**

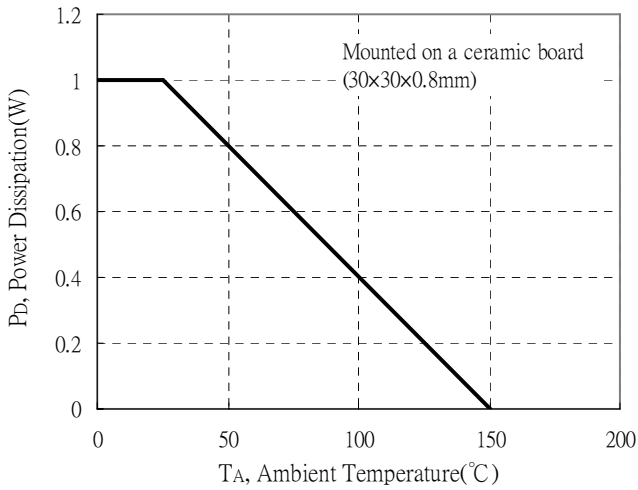
Maximum Safe Operating Area



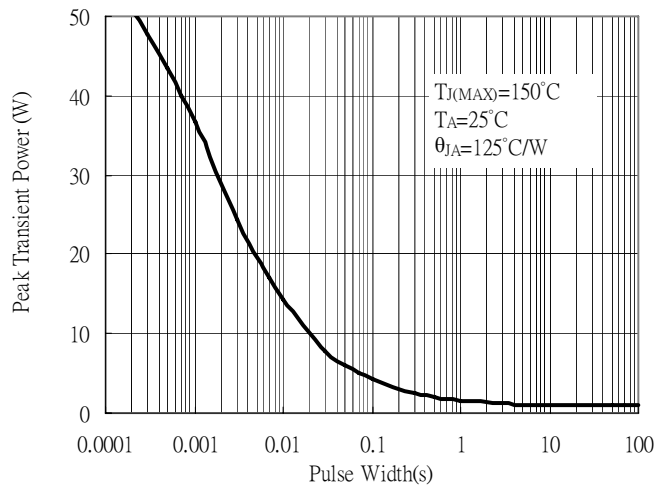
Maximum Drain Current vs Junction Temperature



Power Derating Curve

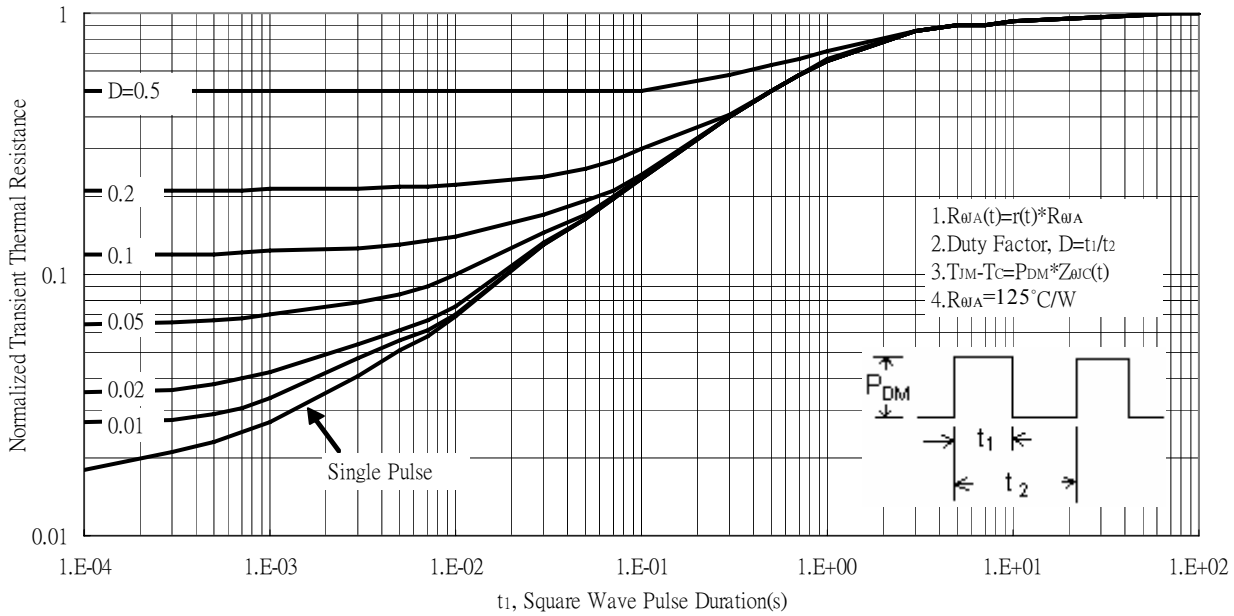


Single Pulse Maximum Power Dissipation



**Typical Characteristics(Cont.)**

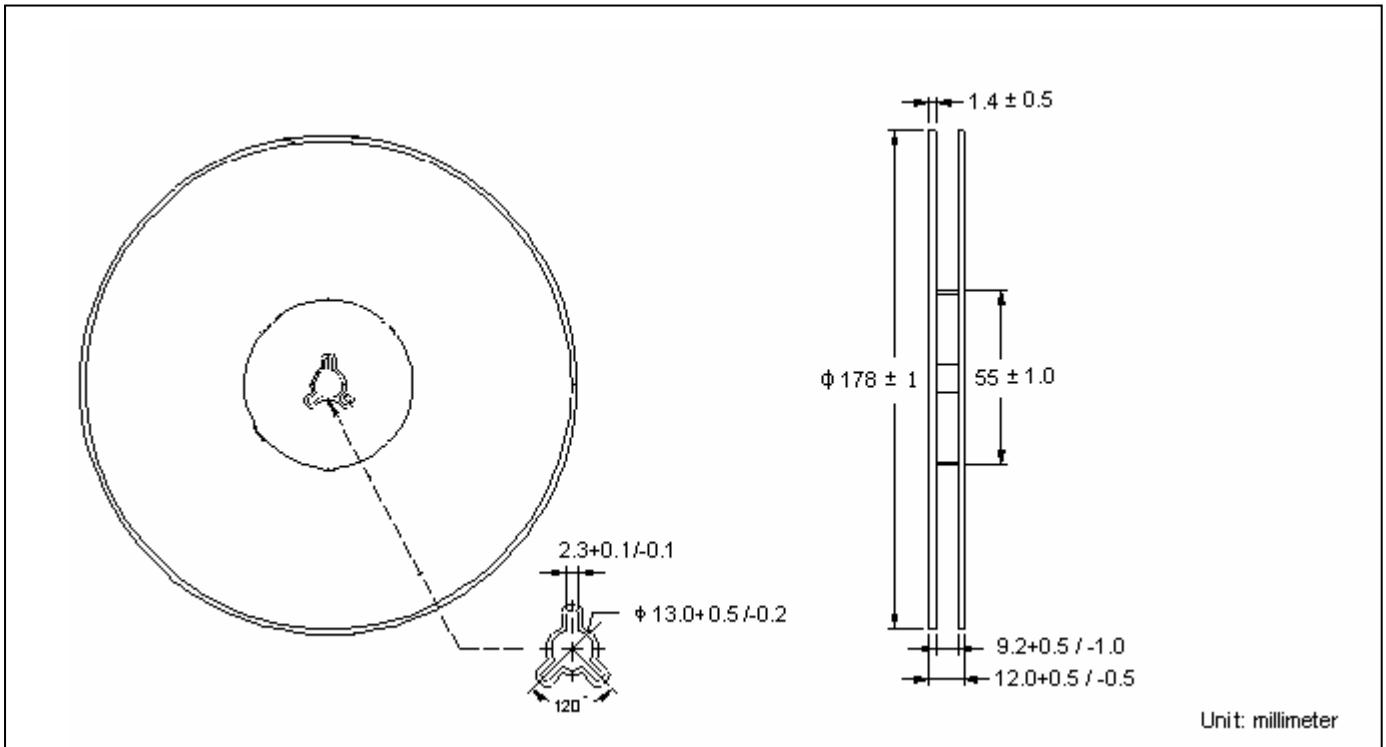
Transient Thermal Response Curves



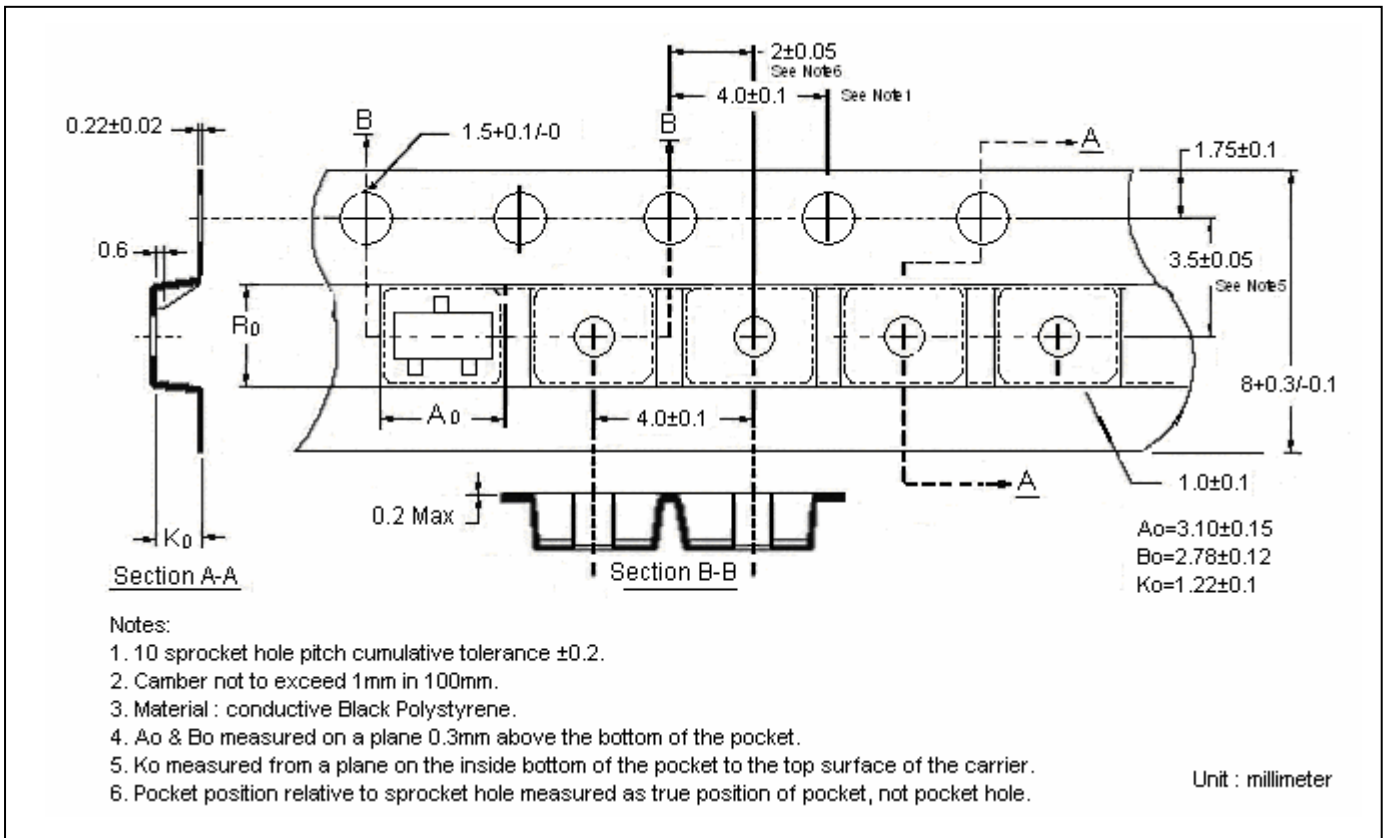
**Ordering Information**

Device	Package	Shipping
MTBC7N10N3-0-T1-G	SOT-23 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

**Reel Dimension**



**Carrier Tape Dimension**



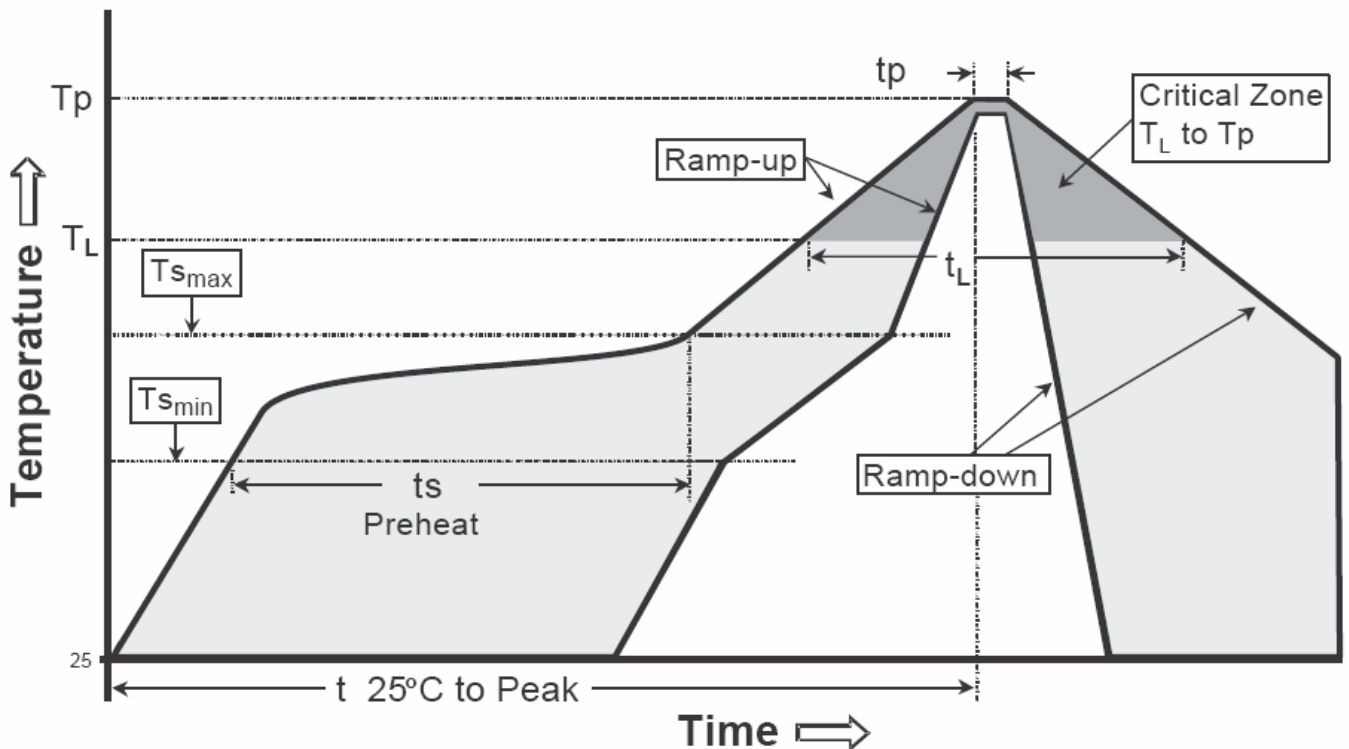
**Notes:**

1. 10 sprocket hole pitch cumulative tolerance  $\pm 0.2$ .
2. Camber not to exceed 1mm in 100mm.
3. Material : conductive Black Polystyrene.
4.  $A_o$  &  $B_o$  measured on a plane 0.3mm above the bottom of the pocket.
5.  $K_o$  measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**

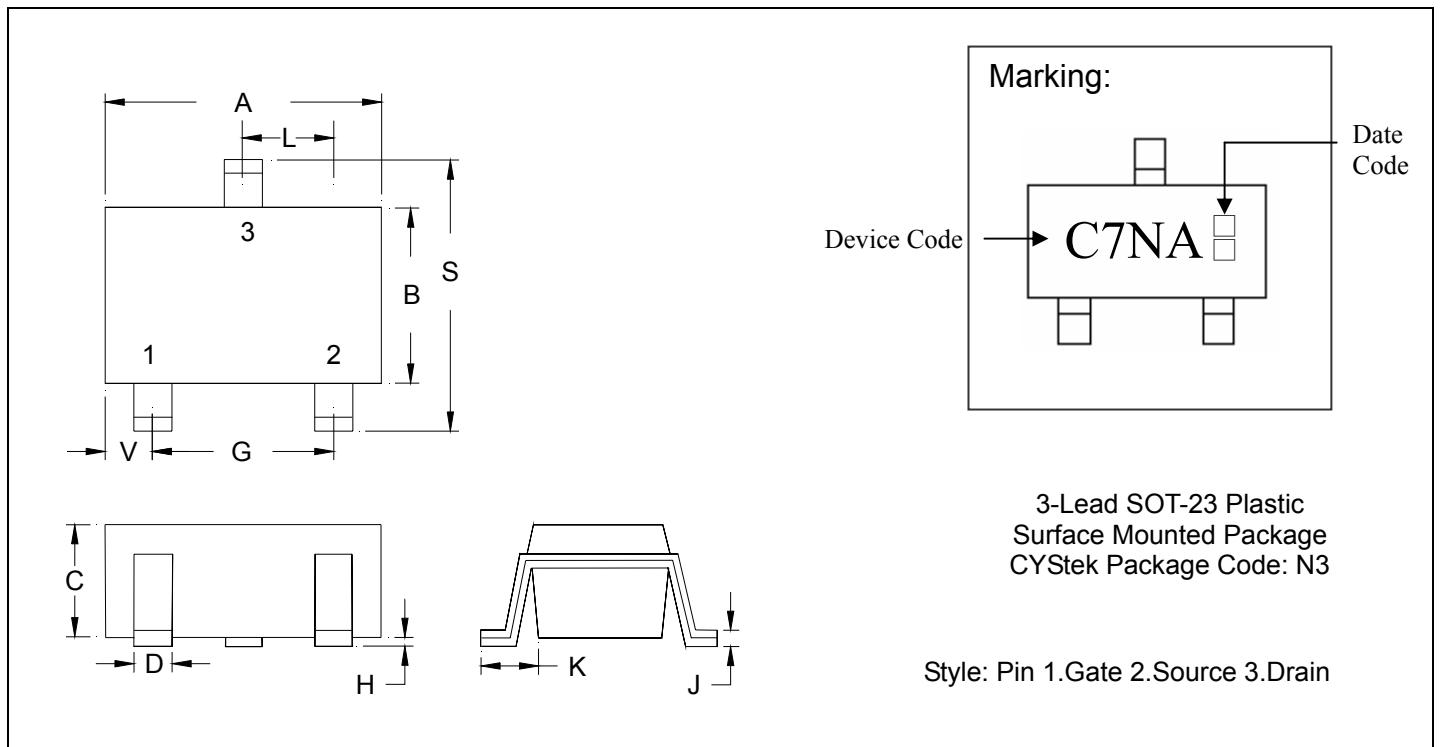


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>s</sub> max to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s</sub> min)	100°C	150°C
-Temperature Max(T <sub>s</sub> max)	150°C	200°C
-Time(t <sub>s</sub> min to t <sub>s</sub> max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.



**SOT-23 Dimension**



\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0034	0.0070	0.085	0.177
B	0.0472	0.0630	1.20	1.60	K	0.0128	0.0266	0.32	0.67
C	0.0335	0.0512	0.89	1.30	L	0.0335	0.0453	0.85	1.15
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1161	2.10	2.95
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0005	0.0040	0.013	0.10					

- Notes:**
- Controlling dimension: millimeters.
  - Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
  - If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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